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| Issue Classification | Application/Control No. | Applicant(s)/Patent Under Reexamination |
| | 10611368 | WU ET AL. |
| | Examiner | Art Unit |
| | Neway, Samuel G | 2626 |

| ORIGINAL | | INTERNATIONAL CLASSIFICATION | | | | | |
|---------------------------|-----------------------------------|------------------------------|---|---|---|-------------|-------------------|
| CLASS | SUBCLASS | CLAIMED | | | | NON-CLAIMED | |
| 704 | 10 | G | 0 | 6 | F | 17 | / 21 (2006.01.01) |
| | | G | 0 | 6 | F | 17 | / 27 (2006.01.01) |
| CROSS REFERENCE(S) | | | | | | | |
| CLASS | SUBCLASS (ONE SUBCLASS PER BLOCK) | | | | | | |
| 704 | 9 | | | | | | |
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| Neway, Samuel G Samuel G. Neway (Assistant Examiner) | 11/07/07 (Date) |  DAVID HUDSPETH SUPERVISORY PATENT EXAMINER TECHNOLOGY CENTER 2600 | Total Claims Allowed: 16 | |
| | | | O.G. Print Claim(s) | O.G. Print Figure |
| (Legal Instruments Examiner) | (Date) | (Primary Examiner) | (Date) | 1 4 B |